

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,362	CHEN ET AL.
Examiner	Art Unit
Donna V. Lui	2629

SEARCHED				
Class	Subclass	Date	Examiner	
345	101	7/2/2006	DL	

INT	INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
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345/87-100 East Text Search (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	7/2/2006	DL